CD4076B Types



Data sheet acquired from Harris Semiconductor SCHS058C – Revised October 2003

CMOS 4-Bit D-Type Registers

High-Voltage Types (20-Volt Rating)

CD4076B types are four-bit registers consisting of D-type flip-flops that feature three-state outputs. Data Disable inputs are provided to control the entry of data into the flip-flops. When both Data Disable inputs are low, data at the D inputs are loaded into their respective flip-flops on the next positive transition of the clock input. Output Disable inputs are also provided. When the Output Disable inputs are both low, the normal logic states of the four outputs are available to the load. The outputs are disabled independently of the clock by a high logic level at either Output Disable input, and present a high impedance.

The CD4076B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

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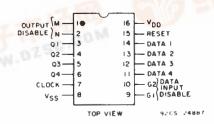
Features:

- Three-state outputs
- Input disabled without gating the clock
- Gated output control lines for enabling or disabling the outputs
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full package temperature range; 100 nA at 18 V and 25°C
- Noise margin over full package temperature range:

1 V at V_{DD} = 5 V 2 V at V_{DD} = 10 V

2.5 V at V_{DD} = 15 V

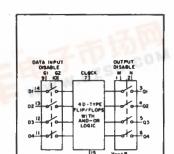
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"



TERMINAL ASSIGNMENT

RECOMMENDED OPERATING CONDITIONS at T_A = 25°C, Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	V _{DD}	L1N	UNITS	
	(V)	Min.	Min. Max.	
Supply Voltage Range (For TA=Full Package Temperature Range)		3	18	v
	5	200		
Data Setup Time, ts	10	80		ns
	15	60	2.00	
	5	200	- /	
Clock Pulse Width, tw	10	100	-	ns
. **	15	80	-	
	5	CO.	3	
Clock Input Frequency, fcl	10	dc	6	MHz
	15		8	
	5	_	15	
Clock Input Rise or Fall Time, trCL,tfCL	10	_	5	μs
	15	_	5	
	5	120	-	
Reset Pulse Width, t _W	10	50		ns
• • • • • • • • • • • • • • • • • • • •	15	40	-	
	5	180	-	
ta Input Disable Setup Time, to	10	100	-	ns
4年一下	15	70	-	



FUNCTIONAL DIAGRAM

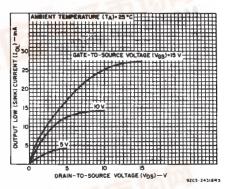


Fig.1 — Typical output low (sink) current characteristics.

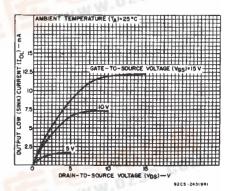


Fig. 2 — Minimum output low (sink) current characteristics.

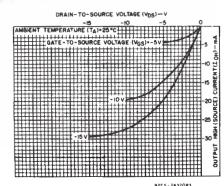


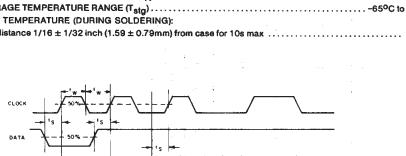
Fig.3 - Typical output high (source) current characteristics.

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CD4076B Types

MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE RANGE, (VDD)	
Voltages referenced to VSS Terminal)	0.5V to +20V
INPUT VOLTAGE RANGE, ALL INPUTS0.5V	0 VDD +0.5V
DC INPUT CURRENT, ANY ONE INPUT	
POWER DISSIPATION PER PACKAGE (PD):	
For T _A = -55°C to +100°C	500mW
For T _A = +100°C to +125°C Derate Linearity at 12mW/	
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	
FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)	100mW
OPERATING-TEMPERATURE RANGE (TA)550	C to +125°C
STORAGE TEMPERATURE RANGE (T _{stg})65°	C to +150°C
LEAD TEMPERATURE (DURING SOLDERING):	
At distance 1/16 \pm 1/32 inch (1.59 \pm 0.79mm) from case for 10s max	+265°C



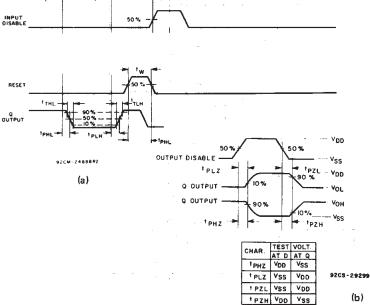


Fig.5 - Functional waveforms for CD40768.

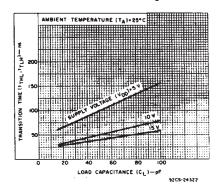


Fig.7 - Typical transition time vs. load capacitance.

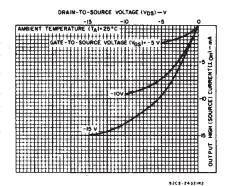
Truth Table

		Data Input Disable		Data	Next State Output	
Reset	Clock	G1	G2	ם	0	<u> </u>
1	х	x	Χ.	х	0	1
0	0	×	×	×	D.	NC
0		i	x	×	o o	NC
0		X7 :	1	×	٥,	NC
0		0	0	-1	-1	ļ
0		0	0	0.	0	
0	1	×	х	×	Q	NC
0	_	×	x	x	Q	NC

When either Output Disable M or N is high, the outputs are disabled (high impedance state), however sequential operation

1 ≡ High Level 0 ≡ Low Level

X = Don't Care NC = No Change



- Minimum output high (source) current characteristics.

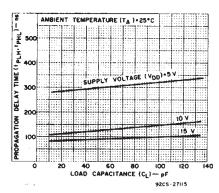


Fig.6 - Typical propagation delay time vs. load capacitance (clock to Q).

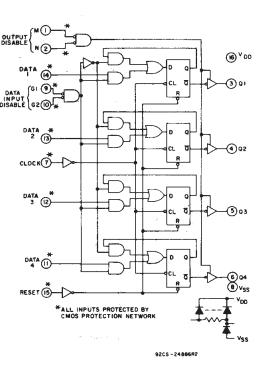


Fig.8 - CD4076B logic diagram.

CD4076B Types

DYNAMIC ELECTRICAL CHARACTERISTICS at $T_A = 25^{\circ}$ C, Input $t_r, t_f = 20$ ns, which is a second of the left of the second of the left of the left

CHARACTERISTIC	TEST CONDITIONS			LIMIT	rs	UNITS	
		V _{DD} V	Min.	Typ.	Max.	1	
Propagation Delay Time: Clock to Q Output, tpHL, tpLH		5 10 15			600 250 180		
Reset, tPHL		5 10 15		230 100 75	460 200 150		en e
3-State Output 1 or 0 to High Impedance, tpHZ, tpLZ	R _L =1kΩ	5° 10 15	ŧ	150 75 60	300 150 120	ns	Light Committee Albert Committee
3-State High Impedance to 1 or 0 Output, tpZH, tpZL	R _L = 1 kΩ	5 10 15		150 75 60	300 150 120		
Transition Time, t _{THL} t _{TLH}		5 10 15		100 50 40	200 100 80	ns	e e
Maximum Clock Input Frequency, f _{CL}		5 10 15	3 6 8	6 12 16		MHz	
Minimum Clock Pulse Width, t _W		5 10 15		100 50 40	200 100 80	ns:	
Maximum Clock Input Rise or Fall Time, of troletcle		5 10 15	15 5 5	-		μs -	,
Minimum Reset Pulse With, t _W		5 10 15	- -	60 25 20	120 50 40	ns	
Minimum Data Setup Time, t _S		5 10 15	 -	100 40 30	200 80 60	ns	
Minimum Data Input Disable Setup Time, t _S		5 . 10 15	-	90 50 35	180 100 70	ns	
Input Capacitance, CIN	Any Input	<u> </u>		5	7.5	pF	

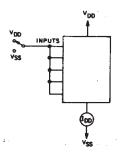


Fig.11 - Quiescent device current test circuit.

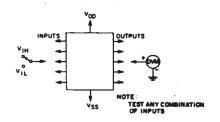


Fig. 12 - Input voltage test circuit.

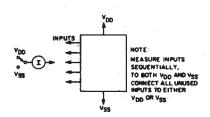


Fig. 13 - Input current test circuit.

STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	CON	NS	LIMITS AT INDICATED TEMPERATURES (°C)							IIIIITA	
ISTIC	Vo	VO VIN VDD					+25		UNITS		
	(V)	(V)	(V)	-55	-40	+85	+125	Min.	Тур.	Max.]
Quiescent Device		0,5	5	5	5	150	150	-	0.04	5	
Current,	-	0,10	10	10	10	300	300	-	0.04	10	
IDD Max.		0,15	15	20	20	600	600	· -	0.04	20	μΑ
	_	0,20	20	100	100	3000	3000	-	0.08	100	
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1	-	
(Sink) Current	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	. –	
10L Min.	1.5	0,15	15	4.2	4	2.8	2.4	34	6.8		1
Output High	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	_	mA
(Source)	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	<u> </u>	
Current,	9.5	0,10	10	-1.6	-1.5	1.1	-0.9	-1.3	-2.6	-	
IOH Min.	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	-	
Output Voltage:	-	0,5	5 ,		0	.05		_	0	0.05	٧
Low Level, VOL Max.	_	0,10	10	11	,0	.05		_	0	0.05	
AOL Max.	-	0,15	15		0	.05		_	0	0.05	
Output Voltage:	_	0,5	5		4	.95		4.95	5	_	
High-Level,	-	0,10	10		9	.95		9,95	10	-	
VOH Min.		0,15	15		14	.95		14.95	15	_	
Input Low	0.5, 4.5	-	5		1	.5		_		1.5	
Voltage,	1, 9		10		****	3			_	3	
VIL Max.	1.5,13.5	_	15			4		-	_	4	
Input High	0.5, 4.5	-	5		3	1.5		3.5	-	_	ν.
Voltage,	1, 9	_	10			7		7	_	_	
VIH Min.	1.5,13.5	~	15		1	1		11	_	_	
Input Current IJN Max.		0,18	18	±0.1	±0.1	±1	±1	_	±10-5	±0.1	μΑ
3-State Output Leakage Current IOUT Max	0,18	0,18	18	±0.4	±0.4	±12	±12	_	±10-4	±0.4	μА

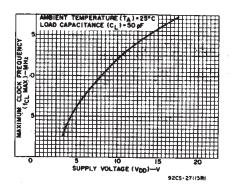


Fig.9 — Typical maximum clock input frequency vs. supply voltage.

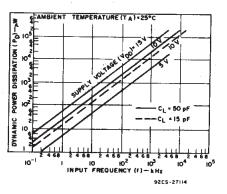
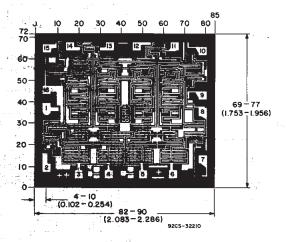


Fig. 10 — Typical dynamic power dissipation vs. frequency.



Dimensions and pad layout for CD4076BH

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10^{-3}) inch).



PACKAGE OPTION ADDENDUM

28-Feb-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CD4076BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD4076BF	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD4076BF3A	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD4076BM	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4076BM96	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4076BMT	ACTIVE	SOIC	D	16	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4076BNSR	ACTIVE	SO	NS	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4076BPW	ACTIVE	TSSOP	PW	16	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4076BPWR	ACTIVE	TSSOP	PW	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not yet available Lead (Pb-Free).

Pb-Free (RoHS): Tl's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

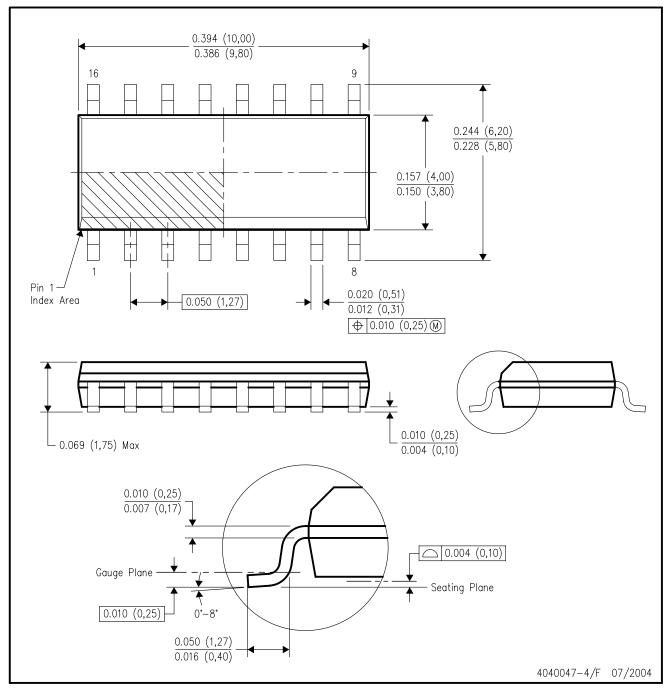
16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.

D (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.

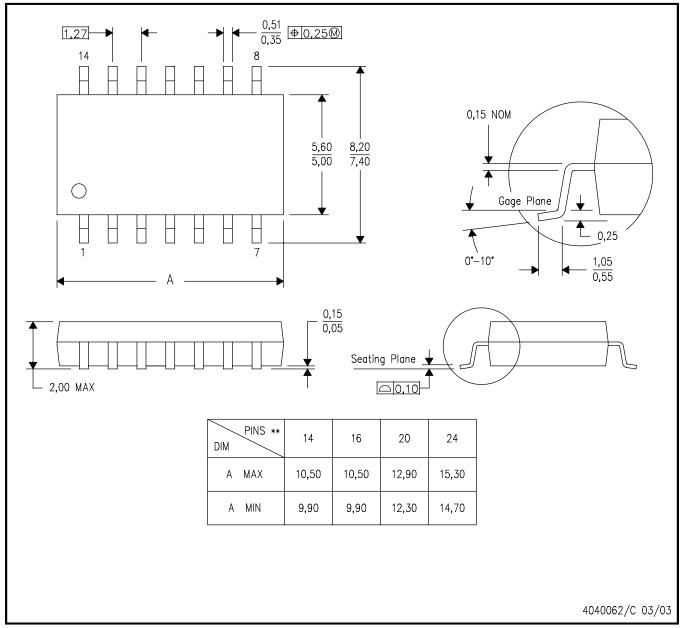


MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- . All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153

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